Lightning Talk: Measuring Spectral Distortions

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B-Mode Comparison





PIXIE and Spectral Distortions



Zero means zero: No fringes if sky is a blackbody



Adventures in Fourier Space

Fringe Pattern vs Frequency Spectrum



Adventures in Fourier Space Channel Selection



Get N samples of fringe pattern as phase delay goes from -L to +L

Maximum phase delay sets channel width (hence lowest frequency)

 $\Delta \nu = {}^{c}/{}_{L}$

Number of samples N sets highest frequency $\nu_i = \Delta \nu, 2\Delta \nu, 3\Delta \nu, \dots, \frac{N}{2} \Delta \nu$

Sample more often → Get more (higher frequency) channels Increase mirror throw → Decrease channel width (go to lower frequencies)

More frequency channels $\leftarrow \rightarrow$ Higher sampling rate (data rate)

Adventures in Fourier Space Channel Shape



Photometer passbands set by filters Complicated shape Hard to control at few-percent level



FTS channel shape set by apodization
Trade resolution vs channel-to-channel correlations
Uniform sampling → Sync function (ugly)
Weighted sampling → Nearest-neighbors (nice)

Channel shape and channel-to-channel correlations are entirely deterministic! Bonus: Pick bands to force CO lines into center of every Nth channel

Systematic Errors I

How Black is Black Enough?





Calibrator is based on ARCADE design Measured black to -60 dB

Is this good enough?



Systematic Errors I

The Importance of Nulling

Where does the reflected ray go?

Reflected ray "sees" instrument wall instead of calibrator

But ...

Instrument, calibrator, and sky are all within a few mK of each other

So ...

Error signal is 10⁻⁶ x (few mK difference) or just a few nK (before correction)

Bonus: Error signal flips sign when calibrator is hotter/colder than wall

Vary calibrator and wall temps to isolate and remove error signal

Sub-nK residual at noise limit of entire mission



Backwards ray trace: From detector to calibrator





Maximum ∆T few m	Κ
Mirror Emissivity	x 0.01 📫 tens of uK
Left/Right Asymmetry	x 0.01 📫 few hundred nK
Swap hot vs cold	x 0.01 📫 few nK
Uncorrected Error	few nK (with blue-ish tinge)
Corrected Error	<< 1 nK

Never rely on any single cancellation

Systematic Errors III Beam Patterns



 $P_{Lx} = 1/2 \int \{ (E_{Ax}^2 + E_{By}^2) + (E_{Ax}^2 - E_{By}^2) \cos(4z\omega/c) \} d\omega$ $P_{Ly} = 1/2 \int \{ (E_{Ay}^2 + E_{Bx}^2) + (E_{Ay}^2 - E_{Bx}^2) \cos(4z\omega/c) \} d\omega$ $P_{Rx} = 1/2 \int \{ (E_{Ay}^2 + E_{Bx}^2) + (E_{Bx}^2 - E_{Ay}^2) \cos(4z\omega/c) \} d\omega$ $P_{Ry} = 1/2 \int \{ (E_{Ax}^2 + E_{By}^2) + (E_{By}^2 - E_{Ax}^2) \cos(4z\omega/c) \} d\omega$

Signals depend on differential beam pattern x pol on A side – y pol on B side

By design, roles of x and y are reversed in A side vs B side Systematic errors are thus *second-order* Depend on the (A-B) difference of the (x-y) polarization

Note that double-difference cancellation occurs in hardware Post-detection differences of individual detectors allow additional cancellations

Kogut & Fixsen 2018, arXiv:1801.08971



)elay)

ets Fourier-transformed t bins of synthesized spectra **ng in CMB maps**



Peak at zero phase delayprovides before-and-after referencefor detector time constants126,000,000 times per detector



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Permutations!

Exploit multiple internal symmetries

- x vs y polarization
- L vs R concentrators
 - A vs B beams
 - Real vs imaginary FFT

Jackknife tests use full data set

PIXIE and Spectral Distortions



The Path to Sensitivity

How Low Can You Go?

FTS Penalty for Low-Frequency Channels

All the power

all the time

Sample

Fringe Pattern

hits the detector



$$\Delta \nu = c/L$$

Test: Increase throw by factor of 2 This decreases integration time per sample, increasing noise per sample by root(2)

But there are now twice as many samples in FTS, so noise in frequency domain increases by another root(2)

Noise per synthesized bin larger by factor of 2 Continuum sources can co-add over bins Integrated noise then larger by only root(2)

Spectral Distortion Sensitivity Scales as Sqrt{ $\Delta\nu$ } Hard to win by adding low-frequency channels while keeping full range*

Adding Low-Frequency Sensitivity



Adventures in Fourier Space Signal to Noise Ratio



$$NEP_{photon}^{2} = \frac{2A\Omega}{c^{2}} \frac{(kT)^{5}}{h^{3}} \int \alpha \epsilon f \frac{x^{4}}{e^{x} - 1} \left(1 + \frac{\alpha \epsilon f}{e^{x} - 1} \right) dx$$
Photon noise ~ $(A\Omega)^{1/2}$
$$\delta I_{\nu} = \frac{\delta P}{A\Omega \ \Delta \nu \ (\alpha \epsilon f)}$$
Signal ~ $(A\Omega)$

Good news: Signal to noise ratio improves as $(A\Omega)^{1/2}$ Better news: nK sensitivity using only 4 bolometers



PIXIE polarization-sensitive bolometer 30x collecting area as Planck bolometers

Instrument and Observatory



The Path to Sensitivity

How Big Can You Grow?

Photon Noise Limit: Sensitivity improves as $(A\Omega)^{1/2}$ Can we just make PIXIE bigger?

Test: Increase all dimensions x3 (area x9) Problem: Dispersion washes out signal Solution: Slower optics

But slower optics reduces solid angle Ω , requiring increase in area to compensate (or accept some loss in sensitivity)



50 cm primary mirrors 13 cm FTS mirrors FTS box 50 cm x 20 cm x 80 cm \rightarrow 4 x 2 x 6 meters

 \rightarrow 3 meters diameter each \rightarrow 1 meter each

Bad: FTS grows from of size carry-on luggage to size of a bus! Better to adopt ground-based approach and clone the instrument